

<b>Notice of References Cited</b>	Application/Control No. 10/690,626	Applicant(s)/Patent Under Reexamination SMALL ET AL.	
	Examiner Kin-Chan Chen	Art Unit 1765	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,447,603	09-1995	Michalowski et al.	162/181.4
*	B	US-2003/0017785	01-2003	Ueda et al.	451/41
*	C	US-4,732,887	03-1988	Obanawa et al.	502/402
*	D	US-6,156,661	12-2000	Small, Robert J.	438/692
*	E	US-6,276,372	08-2001	Lee, Wai Mun	134/1.3
*	F	US-6,561,876	05-2003	Tateyama et al.	451/41
*	G	US-6,117,775	09-2000	Kondo et al.	438/690
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.